## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10779858	MEYER, FRANK
Examiner	Art Unit
Ponikiewski, Tomasz	2165

SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES				
Search Notes	Date	Examiner		
updated search	3/21/07	TP		
consulted with Neveen Abel-Jalil	3/21/07	TP		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		

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